

COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	BV _{DSS}	R _{DS(ON)} Max	I _{D MAX} T _A = +25°C
Q1	20V	$25m\Omega$ @ $V_{GS} = 4.5V$	6.0A
N-Channel	200	$35m\Omega$ @ $V_{GS} = 2.5V$	5.1A
Q2 -20V		75mΩ @ V _{GS} = -4.5V	-3.5A
P-Channel	- 20V	140mΩ @ V _{GS} = -2.5V	-2.5A

Features

- PCB Footprint of 4mm²
- Low On-Resistance
- Low Input Capacitance
- Low Profile, 0.6mm Maximum Height
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) yet maintain superior switching performance, which makes it ideal for high-efficiency power management applications.

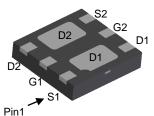
U-DFN2020-6 (Type B)

- Load Switch
- Power Management Functions
- Portable Power Adaptors

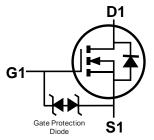
Mechanical Data

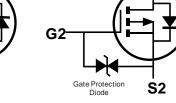
- Case: U-DFN2020-6 (Type B)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208
- Terminals Connections: See Diagram Below
- · Weight: 0.0065 grams (Approximate)





Bottom View





N-Channel MOSFET

P-Channel MOSFET

D2

Bottom View Internal Schematic

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC2025UFDB-7	U-DFN2020-6 (Type B)	3000/Tape & Reel
DMC2025UFDB-13	U-DFN2020-6 (Type B)	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, see https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



O4 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: F = 2018) M = Month (ex: 9 = September)

Date Code Key

	,											
Year	2017	2018	20)19	2020	2021		2022	2023	20:	24	2025
Code	Е	F	(G	Н	ı		J	K	L	-	M
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1 N-CHANNEL	Q2 P-CHANNEL	Unit		
Drain-Source Voltage			V_{DSS}	20	-20	V
Gate-Source Voltage	V_{GSS}	±10	±8	V		
			l _D	6.0 4.8	-3.5 -2.8	А
Maximum Continuous Body Diode Forward Curre	I _S	2	-1.0	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle =	I _{DM}	20	-10	Α		
Avalanche Current (L = 0.1mH) (Note 7)	I _{AS}	8	-13	Α		
Avalanche Energy (L = 0.1mH) (Note 7)	•		Eas	8	8.5	mJ

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	P_{D}	0.7	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R _{OJA}	178	°C/W
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$	P _D	1.4	W
Thermal Resistance, Junction to Ambient (Note 6)	R _{OJA}	92	°C/W	
Thermal Resistance, Junction to Case (Note 6)	R _{eJC}	30	C/VV	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics Q1 N-CHANNEL (@ T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV _{DSS}	20	l	_	V	$V_{GS} = 0V, I_D = 250\mu A$		
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}		I	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$		
Gate-Source Leakage	I _{GSS}		I	±10	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)								
Gate Threshold Voltage	V _{GS(TH)}	0.5	1	1.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		
Static Drain-Source On-Resistance	D		l	25	mΩ	$V_{GS} = 4.5V, I_D = 4A$		
Static Drain-Source On-Resistance	R _{DS(ON)}	_		35	11122	$V_{GS} = 2.5V, I_D = 4A$		
Diode Forward Voltage	V_{SD}	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 5A$		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	C _{iss}	_	486	_		V _{DS} = 10V, V _{GS} = 0V, f = 1.0MHz		
Output Capacitance	Coss	_	92	_	pF			
Reverse Transfer Capacitance	C _{rss}	_	77	_				
Gate Resistance	R_g	_	3.2	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$		
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	5.9	_				
Total Gate Charge (V _{GS} = 10V)	Qg	_	12.3	_	nC	101/ 1 0 54		
Gate-Source Charge	Q _{gs}	_	0.8	_	IIC	$V_{DS} = 10V, I_{D} = 6.5A$		
Gate-Drain Charge	Q _{qd}	_	2.2	_				
Turn-On Delay Time	t _{D(ON)}	_	3.4	_				
Turn-On Rise Time	t _R	_	5.4	_		$V_{DS} = 10V, V_{GS} = 4.5V,$		
Turn-Off Delay Time	t _{D(OFF)}	_	17.6	_	ns	$R_q = 6\Omega$, $R_L = 10\Omega$, $I_D = 1A$		
Turn-Off Fall Time	t _F	_	9.3	_				
Reverse Recovery Time	t _{RR}	_	7.7	_	ns	I _F = 1A, di/dt = 100A/μs		
Reverse Recovery Charge	Q_{RR}		1.5	_	nC	I _F = 1A, di/dt = 100A/μs		



Electrical Characteristics Q2 P-CHANNEL (@ T_A = +25°C, unless otherwise specified.)

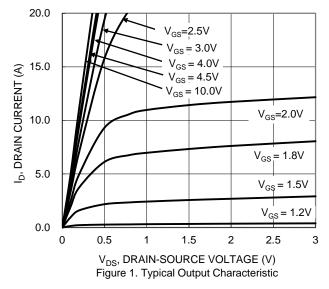
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV _{DSS}	-20	1	-	V	$V_{GS} = 0V, I_{D} = -250\mu A$		
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	-1.0	μΑ	$V_{DS} = -20V, V_{GS} = 0V$		
Gate-Source Leakage	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)						•		
Gate Threshold Voltage	V _{GS(TH)}	-0.35	_	-1.4	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		
Static Drain-Source On-Resistance		_	_	75	mΩ	$V_{GS} = -4.5V, I_D = -2.9A$		
Static Dialii-Source Oil-Resistance	R _{DS(ON)}	_	_	140	11122	$V_{GS} = -2.5V$, $I_D = -2.3A$		
Diode Forward Voltage	V _{SD}	_	_	-1.2	V	V _{GS} = 0V, I _S = -3.0A		
DYNAMIC CHARACTERISTICS (Note 9)					•	•		
Input Capacitance	C _{iss}	_	642	_	pF	.,, .,		
Output Capacitance	Coss	_	98	_	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz		
Reverse Transfer Capacitance	C _{rss}	_	87	_	pF	-1 = 1.0ivii iz		
Gate Resistance	Rg	_	26.5	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$		
Total Gate Charge (V _{GS} = -4.5V)	0	_	8.8	_	nC			
Total Gate Charge (V _{GS} = -8V)	Q_g	_	15	_	nC],, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		
Gate-Source Charge	Q _{gs}	_	0.9	_	nC	$V_{DS} = -10V, I_{D} = -3.7A$		
Gate-Drain Charge	Q _{gd}	_	2.9	_	nC	7		
Turn-On Delay Time	t _{D(ON)}	_	5.5	_	ns			
Turn-On Rise Time	t _R	_	22.6		ns	$V_{DD} = -10V, V_{GS} = -4.5V,$		
Turn-Off Delay Time	t _{D(OFF)}	_	34.1	_	ns	$R_L = 3.3\Omega$, $R_g = 1\Omega$		
Turn-Off Fall Time	t _F	_	34.3	_	ns	1		
Body Diode Reverse Recovery Time	t _{RR}	_	13	_	ns	$I_S = -3.0A$, $dI/dt = 100A/\mu s$		
Body Diode Reverse Recovery Charge	Q _{RR}	_	3.3	_	nC	$I_S = -3.0A$, $dI/dt = 100A/\mu s$		

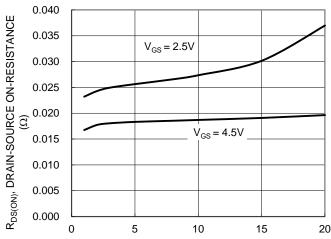
Notes:

- 5. Device mounted on FR-4 substrate PCB, 2oz copper, with minimum recommended pad layout. 6. Device mounted on FR-4 substrate PCB, 2oz copper, with 1inch square copper plate. 7. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_{J} = +25°C. 8. Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to product testing.



Typical Characteristics—N-CHANNEL





I_D, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

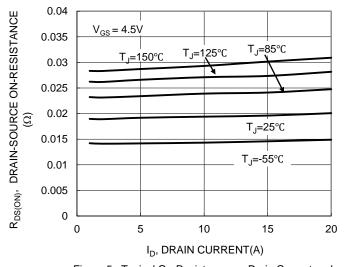
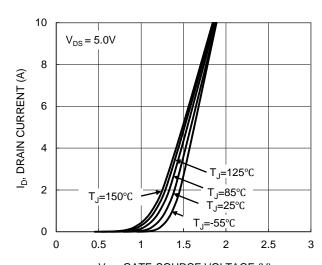
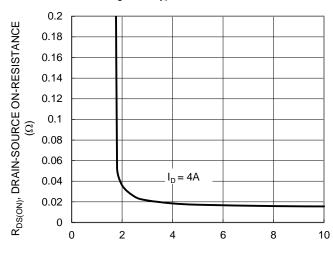


Figure 5. Typical On-Resistance vs. Drain Current and Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 4. Typical Transfer Characteristic

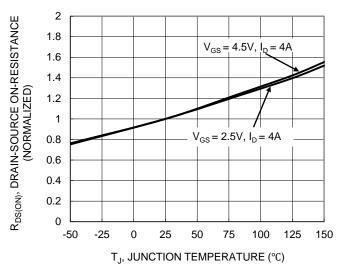


Figure 6. On-Resistance Variation with Temperature



Typical Characteristics--N-CHANNEL (continued)

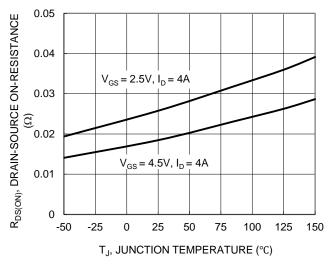


Figure 7. On-Resistance Variation with Temperature

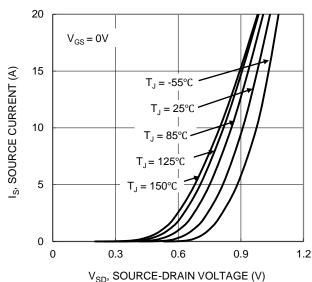


Figure 9. Diode Forward Voltage vs. Current

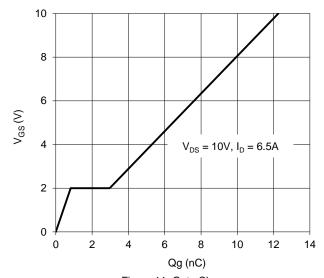


Figure 11. Gate Charge

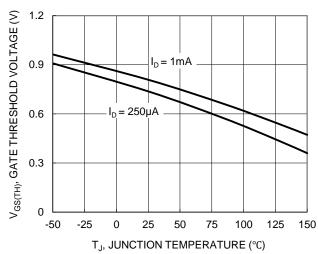


Figure 8. Gate Threshold Variation vs. Junction Temperature

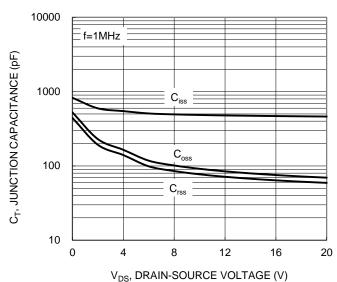
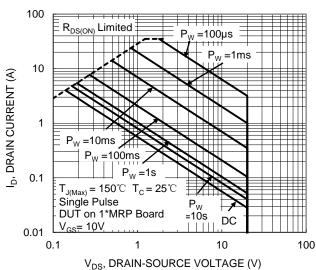
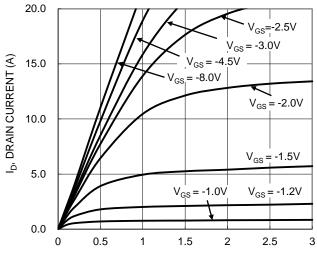


Figure 10. Typical Junction Capacitance

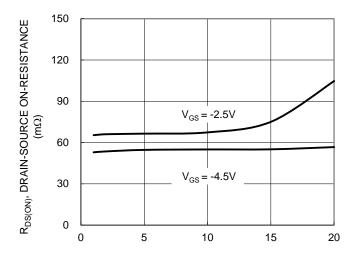




Typical Characteristics—P-CHANNEL



 V_{DS} , DRAIN-SOURCE VOLTAGE(V) Figure 13. Typical Output Characteristic



I_D, DRAIN-SOURCE CURRENT (A) Figure 15. Typical On-Resistance vs. Drain Current and Gate Voltage

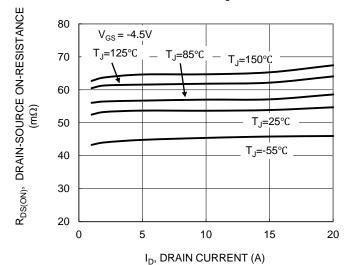


Figure 17. Typical On-Resistance vs. Drain Current and Temperature

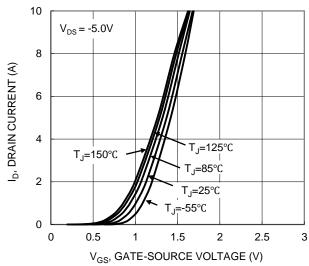


Figure 14. Typical Transfer Characteristic

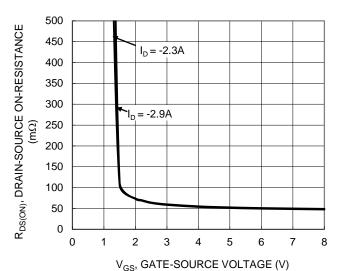


Figure 16. Typical Transfer Characteristic

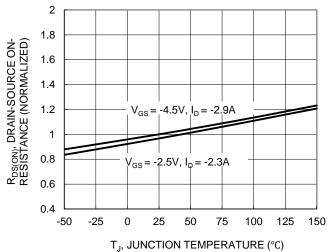


Figure 18. On-Resistance Variation with Temperature



Typical Characteristics—P-CHANNEL (continued)

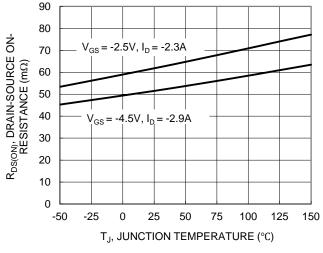
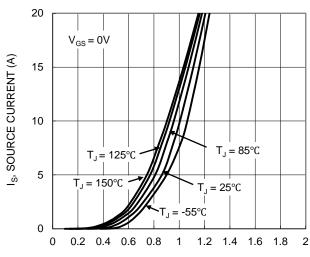


Figure 19. On-Resistance Variation with Temperature



V_{SD}, SOURCE-DRAIN VOLTAGE (V)
Figure 21. Diode Forward Voltage vs. Current

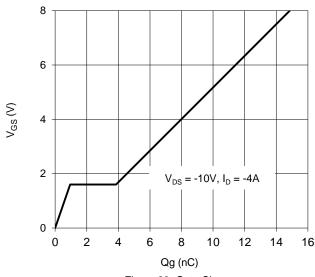
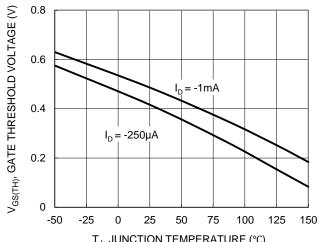
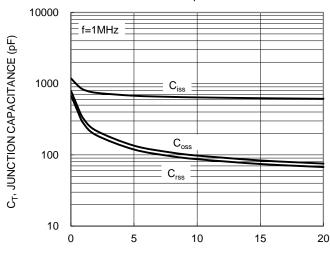


Figure 23. Gate Charge



 T_J , JUNCTION TEMPERATURE (°C) Figure 20. Gate Threshold Variation vs. Junction Temperature



V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 22. Typical Junction Capacitance

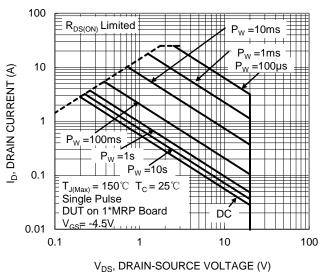


Figure 24. SOA, Safe Operation Area



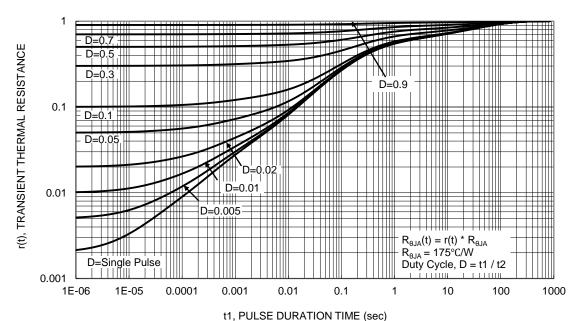


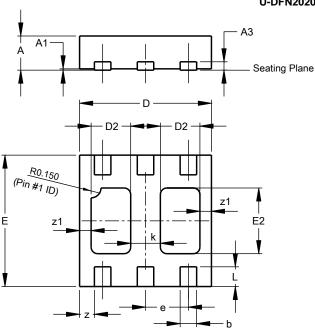
Figure 25. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

U-DFN2020-6 (Type B)

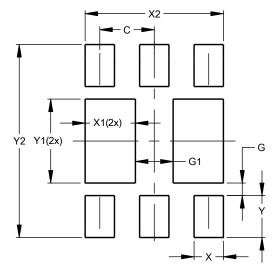


U-DFN2020-6								
Type B								
Dim	Min	Max	Тур					
Α	0.545	0.605	0.575					
A 1	0.00	0.05	0.02					
A3	_		0.13					
b	0.20	0.30	0.25					
D	1.95	2.075	2.00					
D2	0.50	0.70	0.60					
е	_	_	0.65					
Е	1.95	2.075	2.00					
E2	0.90	1.10	1.00					
k	_	_	0.45					
L	0.25	0.35	0.30					
z		_	0.225					
z1	_	_	0.175					
All Dimensions in mm								

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

U-DFN2020-6 (Type B)



Dimensions	Value
פווטופווסוווט	(in mm)
С	0.650
G	0.150
G1	0.450
Х	0.350
X1	0.600
X2	1.650
Y	0.500
Y1	1.000
Y2	2.300



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